Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	Applicant(s)/Patent under Reexamination	
10/722,912	YOSHIHARA ET AL.		
Examiner	Art Unit		
XIAO M. WU	2629		

SEARCHED				
Class	Subclass	Date	Examiner	
345	87-89 98-100 102	6/20/2006	X.W.	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
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